



IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

**CB TEST CERTIFICATE** 

Product Laboratory equipment

(microscope)

Name and address of the applicant Leica Microsystems CMS GmbH

Ernst-Leitz-Straße 17-37

35578 Wetzlar GERMANY

Name and address of the manufacturer Leica Microsystems CMS GmbH

Ernst-Leitz-Straße 17-37, 35578 Wetzlar, GERMANY

Name and address of the factory

Leica Microsystems Ltd. Shanghai

Floor 1, 2, 3A, 4A, and 6, Building T20-1, 258 Jinzang Road, China (Shanghai) Pilot Free Trade Zone, 201206 Shanghai, PEOPLE'S

REPUBLIC OF CHINA

Zhangjiagang Optical Instrument Co., Ltd

Nanlin Development Zone, 215616 Zhangjiagang City, PEOPLE'S

REPUBLIC OF CHINA

Ratings and principal characteristics Rated Voltage: 100-240 V

Rated frequency: 50/60 Hz
Rated power: 18 VA
Protection class: I

Trademark / Brand (if any) Leica

Model/type Ref. DMi1

Additional information (if necessary)

Certificate DE 3 - 31708 issued 2022-02-03 is replaced by this version due

to technical changes

A sample of the product was tested and found

to be in conformity with

IEC 61010-1:2010

IEC 61010-1:2010/AMD1:2016

IEC 61010-2-101:2018

as shown in the Test Report Ref. No. which forms part of this certificate

713352320

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This CB Test Certificate is issued by the National Certification Body

CB 056257 0267 Rev. 01

Date, 2025-03-25

Es Plear

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**Product Service** 

(Erich Thurner)

TÜV SÜD Product Service GmbH • Certification Body • Ridlerstraße 65 • 80339 Munich • Germany